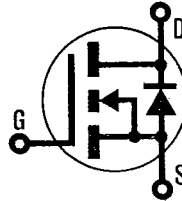




HEXFET® TRANSISTORS

IRFJ340

N-CHANNEL
POWER MOSFETs



IRFJ341

IRFJ342

IRFJ343

400 Volt, 0.55 Ohm HEXFET

The HEXFET® technology is the key to International Rectifier's advanced line of power MOSFET transistors. The efficient geometry and unique processing of the HEXFET design achieve very low on-state resistance combined with high transconductance and great device ruggedness.

The HEXFET transistors also feature all of the well established advantages of MOSFETs such as voltage control, very fast switching, ease of paralleling, and temperature stability of the electrical parameters.

They are well suited for applications such as switching power supplies, motor controls, inverters, choppers, audio amplifiers, and high energy pulse circuits.

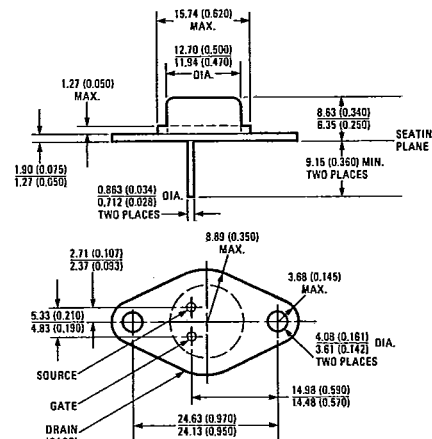
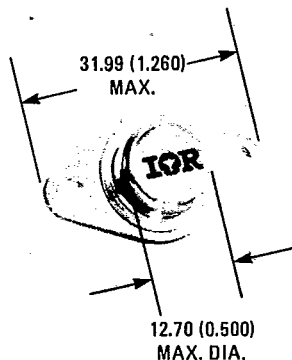
Features:

- Fast Switching
- Low Drive Current
- Ease of Paralleling
- Excellent Temperature Stability

Product Summary

Part Number	V _{DS}	R _{DS(on)}	I _D
IRFJ340	400V	0.55Ω	7.5A
IRFJ341	350V	0.55Ω	7.5A
IRFJ342	400V	0.80Ω	6.0A
IRFJ343	350V	0.80Ω	6.0A

CASE STYLE AND DIMENSIONS

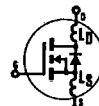


Conforms to JEDEC Case Style TO-213AA (TO-66)
Dimensions in Millimeters and (Inches)

Absolute Maximum Ratings

Parameter	IRFJ340	IRFJ341	IRFJ342	IRFJ343	Units
V_{DS} Drain - Source Voltage ①	400	350	400	350	V
V_{DGR} Drain - Gate Voltage ($R_{GS} = 20\text{ k}\Omega$) ①	400	350	400	350	V
I_D @ $T_C = 25^\circ\text{C}$ Continuous Drain Current	7.5	7.5	6.0	6.0	A
I_D @ $T_C = 100^\circ\text{C}$ Continuous Drain Current	5.0	5.0	4.0	4.0	A
I_{DM} Pulsed Drain Current ③	30	30	25	25	A
V_{GS} Gate - Source Voltage	± 20				V
P_D @ $T_C = 25^\circ\text{C}$ Max. Power Dissipation	70 (See Fig. 14)				W
Linear Derating Factor	0.55 (See Fig. 14)				W/K ④
I_{LM} Inductive Current, Clamped	(See Fig. 15 and 16) $L = 100\mu\text{H}$				A
T_J Operating Junction and Storage Temperature Range	-55 to 150				$^\circ\text{C}$
Lead Temperature	300 (0.063 in. (1.6mm) from case for 10s)				$^\circ\text{C}$

Electrical Characteristics @ $T_C = 25^\circ\text{C}$ (Unless Otherwise Specified)

Parameter	Type	Min.	Typ.	Max.	Units	Test Conditions
BV_{DSS} Drain - Source Breakdown Voltage	IRFJ340	400	—	—	V	$V_{GS} = 0\text{V}$ $I_D = 250\mu\text{A}$
	IRFJ342	—	—	—	—	
	IRFJ341 IRFJ343	350	—	—	V	
$V_{GS(th)}$ Gate Threshold Voltage	ALL	2.0	—	4.0	V	$V_{DS} = V_{GS}$, $I_D = 250\mu\text{A}$
I_{GSS} Gate - Source Leakage Forward	ALL	—	—	100	nA	$V_{GS} = 20\text{V}$
I_{GSS} Gate - Source Leakage Reverse	ALL	—	—	-100	nA	$V_{GS} = -20\text{V}$
I_{DSS} Zero Gate Voltage Drain Current	ALL	—	—	250	μA	$V_{DS} = \text{Max. Rating}$, $V_{GS} = 0\text{V}$
		—	—	1000	μA	$V_{DS} = \text{Max. Rating} \times 0.8$, $V_{GS} = 0\text{V}$, $T_C = 125^\circ\text{C}$
$I_{D(on)}$ On-State Drain Current ②	IRFJ340	7.5	—	—	A	$V_{DS} > I_{D(on)} \times R_{DS(on)max.}$, $V_{GS} = 10\text{V}$
	IRFJ341	—	—	—	—	
	IRFJ342 IRFJ343	6.0	—	—	A	
$R_{DS(on)}$ Static Drain-Source On-State Resistance ②	IRFJ340	—	0.47	0.55	Ω	$V_{GS} = 10\text{V}$, $I_D = 6.2\text{A}$
	IRFJ341	—	—	—	—	
	IRFJ342 IRFJ343	—	0.68	0.80	Ω	
g_{fs} Forward Transconductance ②	ALL	4.0	7.5	—	S (①)	$V_{DS} > I_{D(on)} \times R_{DS(on)max.}$, $I_D = 6.2\text{A}$
C_{iss} Input Capacitance	ALL	—	1250	1600	pF	$V_{GS} = 0\text{V}$, $V_{DS} = 25\text{V}$, $f = 1.0\text{ MHz}$ See Fig. 10
C_{oss} Output Capacitance	ALL	—	300	450	pF	
C_{rss} Reverse Transfer Capacitance	ALL	—	80	150	pF	
$t_{d(on)}$ Turn-On Delay Time	ALL	—	17	35	ns	$V_{DD} = 175\text{V}$, $I_D = 6.2\text{A}$, $Z_\theta = 4.70$ See Fig. 17 (MOSFET switching times are essentially independent of operating temperature.)
t_r Rise Time	ALL	—	5.0	15	ns	
$t_{d(off)}$ Turn-Off Delay Time	ALL	—	45	90	ns	
t_f Fall Time	ALL	—	16	35	ns	$V_{GS} = 10\text{V}$, $I_D = 9.5\text{A}$, $V_{DS} = 0.8 \text{ Max. Rating}$. See Fig. 18 for test circuit. (Gate charge is essentially independent of operating temperature.)
Q_g Total Gate Charge (Gate-Source Plus Gate-Drain)	ALL	—	41	60	nC	
Q_{gs} Gate-Source Charge	ALL	—	18	—	nC	
Q_{gd} Gate-Drain ("Miller") Charge	ALL	—	23	—	nC	Measured between the contact screw on header that is closer to source and gate pins and center of die. Modified MOSFET symbol showing the internal device inductances. 
L_D Internal Drain Inductance	ALL	—	5.0	—	nH	
L_S Internal Source Inductance	ALL	—	12.5	—	nH	Measured from the source pin, 6 mm (0.25 in.) from header and source bonding pad.

Thermal Resistance

R_{thJC} Junction-to-Case	ALL	—	—	1.8	K/W ④	Mounting surface flat, smooth, and greased. Typical socket mount
R_{thCS} Case-to-Sink	ALL	—	0.2	—	K/W ④	
R_{thJA} Junction-to-Ambient	ALL	—	—	50	K/W ④	

Source-Drain Diode Ratings and Characteristics

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I_S	Continuous Source Current (Body Diode)	IRFJ340 IRFJ341	—	—	7.5	A	Modified MOSFET symbol showing the integral reverse P-N junction rectifier.
		IRFJ342 IRFJ343	—	—	6.0	A	
I_{SM}	Pulse Source Current (Body Diode) ③	IRFJ340 IRFJ341	—	—	30	A	
		IRFJ342 IRFJ343	—	—	25	A	
V_{SD}	Diode Forward Voltage ②	IRFJ340 IRFJ341	—	—	2.0	V	$T_C = 25^\circ\text{C}$, $I_S = 7.5$, $V_{GS} = 0\text{V}$
		IRFJ342 IRFJ343	—	—	1.9	V	$T_C = 25^\circ\text{C}$, $I_S = 6.2\text{A}$, $V_{GS} = 0\text{V}$
t_{rr}	Reverse Recovery Time	ALL	—	800	—	ns	$T_J = 150^\circ\text{C}$, $I_F = 7.5\text{A}$, $dI_F/dt = 100\text{A}/\mu\text{s}$
Q_{RR}	Reverse Recovered Charge	ALL	—	5.7	—	μC	$T_J = 150^\circ\text{C}$, $I_F = 7.5\text{A}$, $dI_F/dt = 100\text{A}/\mu\text{s}$
t_{on}	Forward Turn-on Time	ALL	Intrinsic turn-on time is negligible. Turn-on speed is substantially controlled by $L_S + L_D$.				

① $T_J = 25^\circ\text{C}$ to 150°C . ② Pulse Test: Pulse width $\leq 300\mu\text{s}$, Duty Cycle $\leq 2\%$.

③ Repetitive Rating: Pulse width limited by max. junction temperature. See Transient Thermal Impedance Curve (Fig. 5).

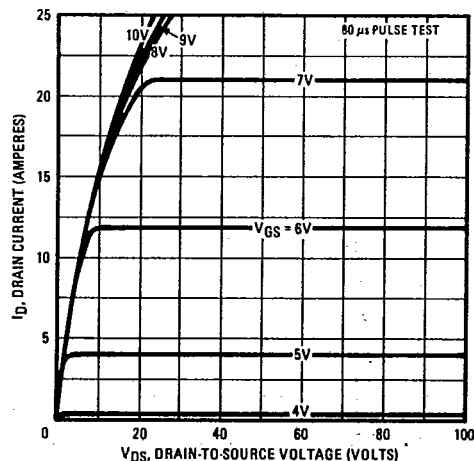
④ $\text{K/W} = ^\circ\text{C/W}$
 $\text{W/K} = \text{W}/^\circ\text{C}$ 

Fig. 1 — Typical Output Characteristics

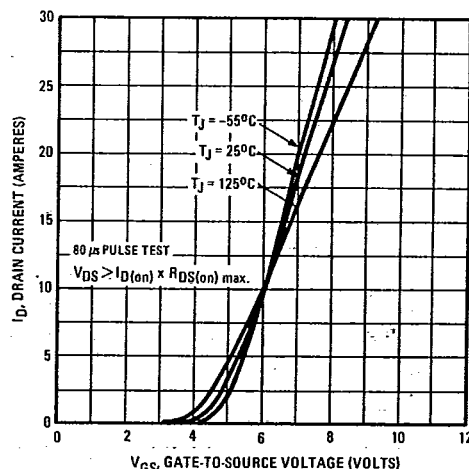


Fig. 2 — Typical Transfer Characteristics

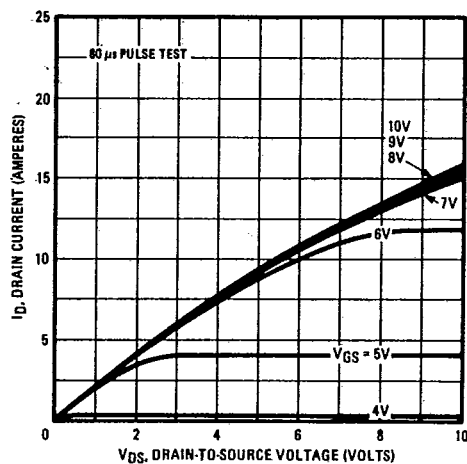


Fig. 3 — Typical Saturation Characteristics

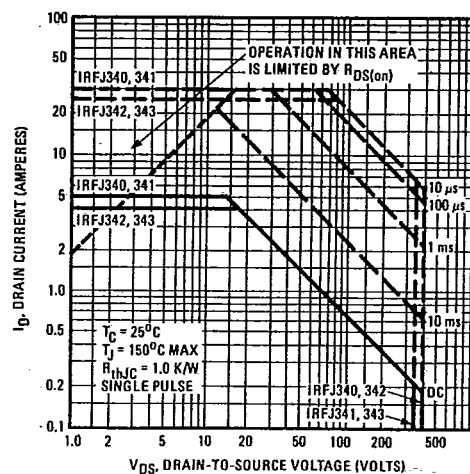


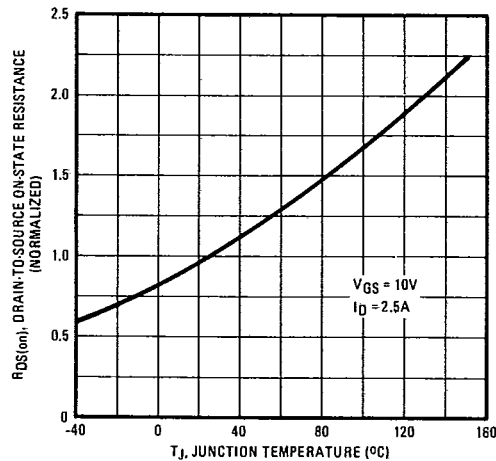
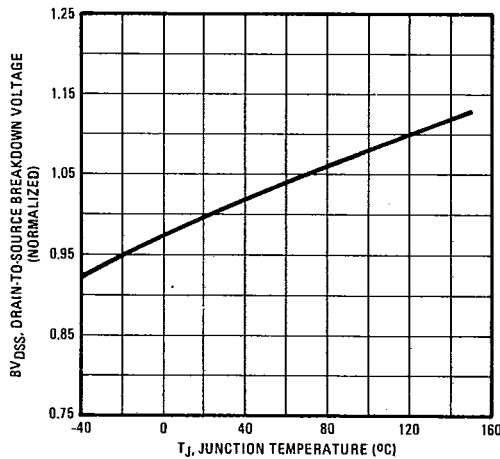
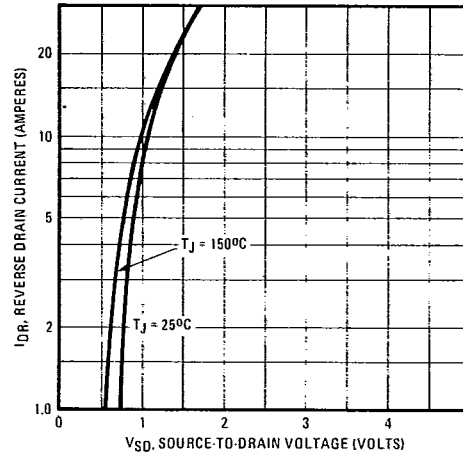
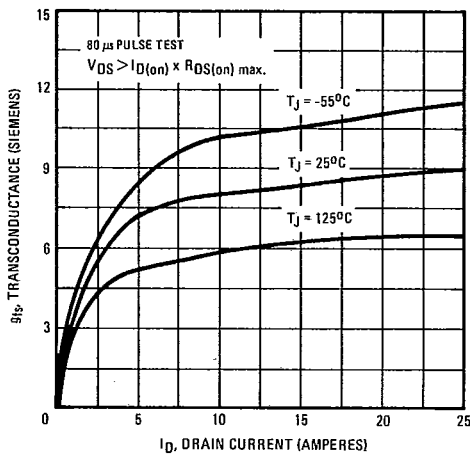
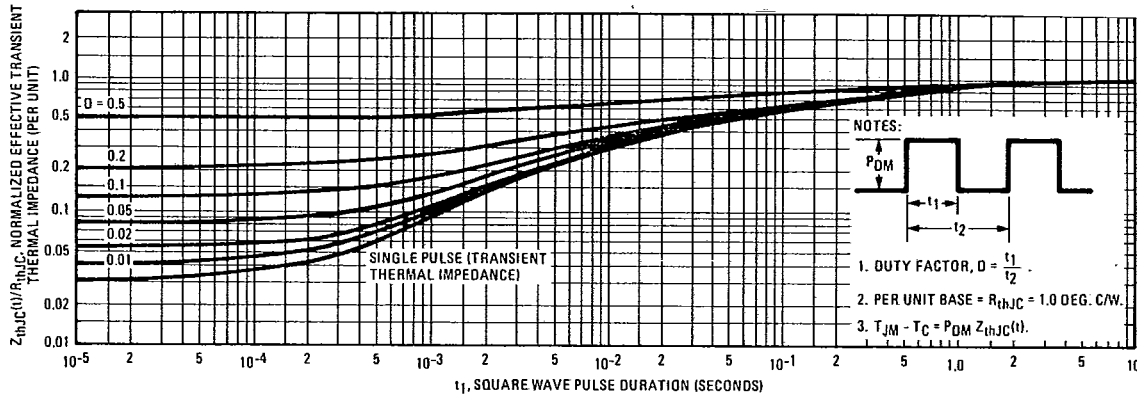
Fig. 4 — Maximum Safe Operating Area

T0-66

IRFJ340, IRFJ341, IRFJ342, IRFJ343 Devices

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IRFJ340, IRFJ341, IRFJ342, IRFJ343 Devices

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INTERNATIONAL RECTIFIER

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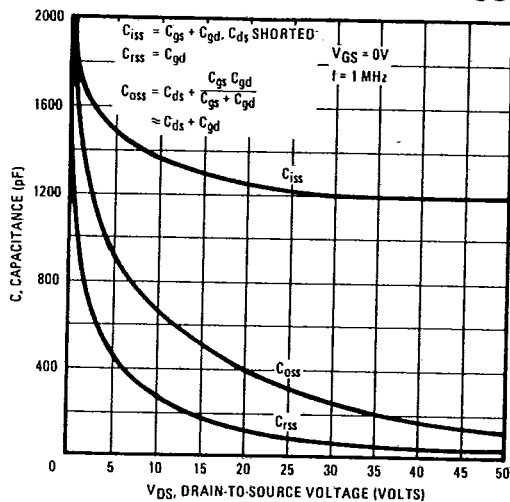


Fig. 10 - Typical Capacitance Vs. Drain-to-Source Voltage

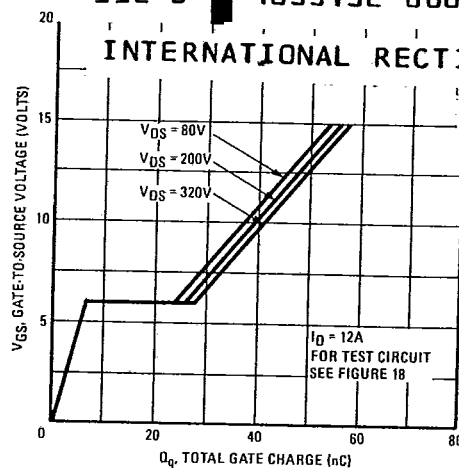


Fig. 11 - Typical Gate Charge Vs. Gate-to-Source Voltage

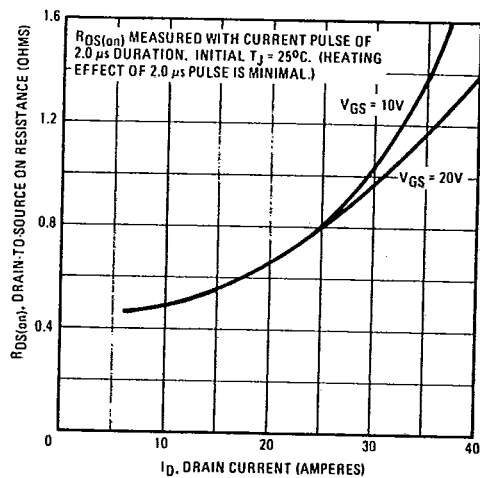


Fig. 12 - Typical On-Resistance Vs. Drain Current

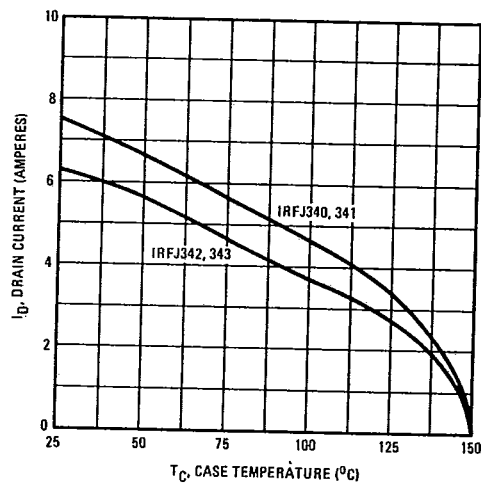


Fig. 13 - Maximum Drain Current Vs. Case Temperature

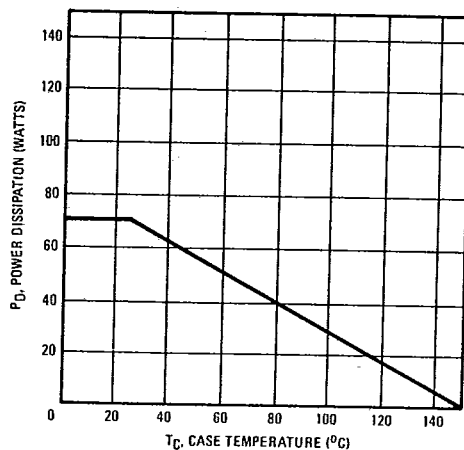


Fig. 14 - Power Vs. Temperature Derating Curve

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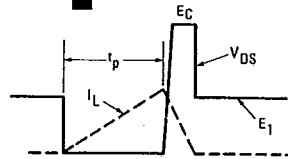


Fig. 16 — Clamped Inductive Waveforms

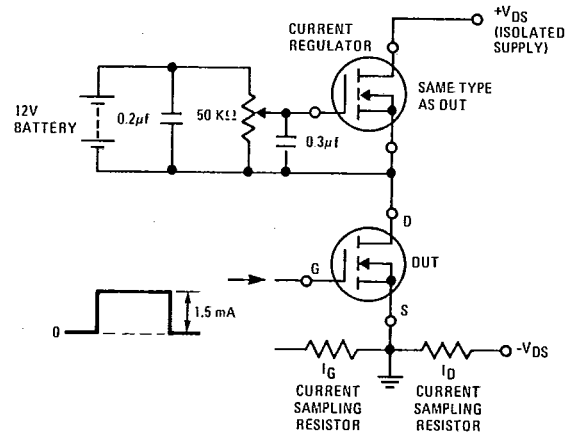


Fig. 18 — Gate Charge Test Circuit